

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination AMI ET AL.	
		Examiner Gregory B. Sefcheck	Art Unit 2616	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0051448 A1	05-2002	Kalkunte et al.	370/389
*	B	US-6,999,416 B2	02-2006	Wang et al.	370/230
*	C	US-6,977,930 B1	12-2005	Epps et al.	370/392
*	D	US-6,882,623 B1	04-2005	Goren et al.	370/230
*	E	US-6,721,324 B1	04-2004	Shinohara, Masayuki	370/395.1
*	F	US-6,556,572 B1	04-2003	Ishida, Hiroshi	370/395.41
*	G	US-6,549,938 B1	04-2003	Kilkki et al.	709/207
*	H	US-6,483,854 B1	11-2002	Klausmeier et al.	370/474
*	I	US-6,473,434 B1	10-2002	Araya et al.	370/412
*	J	US-6,215,767 B1	04-2001	Li, Chia-Chang	370/230
*	K	US-6,167,030 A	12-2000	Kilkki et al.	370/236
*	L	US-5,499,238 A	03-1996	Shon, Seung W.	370/399
*	M	US-5,487,061 A	01-1996	Bray, Thomas A.	370/252

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.